



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005  
& ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540.3-2006

WESCAN CALIBRATION  
 #9-12240 Horseshoe Way  
 Richmond, B.C., V7A 4X9, Canada  
 Malcolm Smith Phone: 604 275 0600

CALIBRATION

Valid To: January 31, 2017

Certificate Number: 1500.02

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1</sup>:

I. Chemical

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
pH – Measuring Equipment <sup>5</sup>	4 pH 7 pH 10 pH	0.010 pH 0.011 pH 0.018 pH	Standard solutions
Electrolytic Conductivity – Measuring Equipment	10 µS/cm 100 µS/cm 1 000 µS/cm 10 000 µS/cm	0.30 µS/cm 0.61 µS/cm 5.3 µS/cm 36 µS/cm	Standard solutions

II. Dimensional

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Angle Blocks	(0 to 30)°	3.1”	Gauge blocks, sine bar, gauging head and amplifier

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Length Standards	(1 to 40) in	(13 + 4.0L) μin	Gauge blocks, gauging head and amplifier
Crimp tools	(0.011 to 0.25) in Above 0.25 in	0.00023 in 0.00023 in	Pin gauges, Supermicrometer <sup>TM6</sup> , digital caliper
Diameter –  External	Up to 10 in  (10 to 24) in	(3.8 + 4.3D) μin  (13 + 4.0D) μin	Supermicrometer <sup>TM6</sup> and gauge blocks  Gauge blocks, gauging head and amplifier
Internal	Up to 12 in	(6.5 + 4.5D) μin	Comparator and gauge blocks
Flatness –  Optical quality	Up to 3 in	4.1 μin	Optical flat
Surface Plate <sup>3</sup>	12 in × 12 in to 12 ft × 12 ft	35 μin	Electronic leveling system
Height Gauges <sup>3,5</sup>	Up to 24 in (24 to 40) in	(1.0 + 3.7L) μin (13 + 3.5L) μin	Gauge blocks
Calipers <sup>3,5</sup>	Up to 40 in	(5.6 + 4.1L) μin	Gauge blocks
Micrometers <sup>3,5</sup> OD ID Depth	Up to 60 in Up to 24 in Up to 12 in	(8.2 + 3.8L) μin (5.5 + 4.0L) μin (2.9 + 3.4L) μin	Gauge blocks Gauge blocks Gauge blocks
Indicators <sup>3,5</sup>	Up to 3 in	(7.0 + 2.8L) μin	Gauge blocks
Indicator Calibrators <sup>3,5</sup>	Up to 2 in	12 μin	Gauge blocks

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Gauge Head/Amplifier	(0.000 1 to 0.2) in	5.4 μin	Gauge blocks
Step Gauges	Up to 6 in	(7.7 + 0.90L) μin	Gauge blocks
ID Instruments <sup>3,5</sup> – Bore Gages, ID Micrometers, and Similar) <sup>3</sup>	Up to 60 in	(5.5 + 4.0L) μin	Gauge blocks, gauging head/amplifier
Thickness Gauges <sup>3,5</sup>	(0.001 to 0.6) in (>0.6 to 1) in	4.7 μin 11 μin	Shims & gauge blocks
Rulers, Tapes <sup>3,5</sup>	Up to 144 in	(15 + 3.5L) μin	Gauge blocks
Sine Bars –  Parallelism  Angle (5 in bar) Angle (10 in bar)	5 in 10 in  (0 to 45)° (0 to 45)°	37 μin 39 μin  5.5” 3.0”	Gauging head and amplifier  Gauge blocks, Supermicrometer <sup>TM6</sup> , gauging head and amplifier
Squares	Up to 18 in	11 μin/in	Master square, gauge blocks
Precision Levels <sup>5</sup>	Up to 12 in	15 μin/in	Sine bar, gauge blocks, surface plate
Protractors <sup>5</sup>	At 0° and 90°  (>0 to <90)°	0.00056°  0.014°	Master square  Sine bar, gauge blocks, master square
Thread Plugs – Major and Pitch Diameter	(0.07 to 10) in	98 μin	Thread wires and Supermicrometer <sup>TM6</sup>

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Area – X-Axis Y-Axis	6 in 5 in	0.86 m·in 0.86 m·in	Optical comparator

### III. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC <sup>2,8</sup> (±)	Comments
DC Voltage – Generate <sup>3</sup>	(0 to 199.9) $\mu$ V (0.2 to 1.999) mV (2 to 19.99) mV (20 to 199.99) mV (0.2 to 1.999) V (2 to 19.99) V (20 to 199.99) V (200 to 1100) V	0.0052 % + 0.46 $\mu$ V 0.00041 % + 0.00047 mV 0.00081 % + 0.00046 mV 0.00082 % + 0.00045 mV 0.00063 % + 0.0000010 V 0.00062 % + 0.0000036 V 0.00077 % + 0.000045 V 0.00089 % + 0.00045 V	Wavetek 4808
DC Voltage – Measure and Generate <sup>3</sup>	(0 to 100) mV 100 mV to 1 V (1 to 10) V (10 to 100) V (100 to 1000) V	8.4 $\mu$ V/V + 1.4 $\mu$ V 7.4 $\mu$ V/V + 3.4 $\mu$ V 9.7 $\mu$ V/V + 2.2 $\mu$ V 9.5 $\mu$ V/V + 0.29 mV 25 $\mu$ V/V + 0.50 mV	Fluke 5520A w/ HP 3458A
Measure Only	(1 to 6) kV	0.15 % - 1.2 V	Fluke 80E-10 w/ HP 3458A opt 002
DC Current – Measure <sup>3</sup>	(0 to 120) nA 100 nA to 1.2 $\mu$ A (1 to 12) $\mu$ A (10 to 120) $\mu$ A 100 $\mu$ A to 1.2 mA (1 to 12) mA (10 to 120) mA 100 mA to 1.05 A  (1 to 3) A (3 to 10) A (10 to 20) A	0.029 % + 73 pA 25 $\mu$ A/A + 68 pA 23 $\mu$ A/A + 0.12 nA 23 $\mu$ A/A + 0.93 nA 23 $\mu$ A/A + 5.9 pA 23 $\mu$ A/A + 59 pA 40 $\mu$ A/A 0.13 % + 12 $\mu$ A  0.016 % + 48 $\mu$ A 0.017 % + 16 $\mu$ A 0.025 % - 0.38 mA	HP 3458A opt 002  Fluke Y5020 and HP 3458A opt 002

Parameter/Equipment	Range	CMC <sup>2,8</sup> (±)	Comments
DC Current – Generate <sup>3</sup>	(0 to 100) nA 100 nA to 1 μA (1 to 10) μA (10 to 100) μA 100 μA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1 A	0.058 % + 100 pA 40 μA/A + 90 pA 22 μA/A + 0.14 nA 23 μA/A + 0.94 nA 23 μA/A + 6.5 pA 23 μA/A + 64 pA 40 μA/A 0.013 % + 12 μA	Fluke 5520A w/ HP 3458A opt 002
Generate only: Torroidal Clamps	(1 to 3) A (3 to 10) A (10 to 20) A	0.016 % +47 μA 0.017 % + 12 μA 0.035 % - 1.4 mA	Fluke 5520A w/ Fluke Y5020 and HP 3458A opt 002
Non-torroidal Clamps	(20 to 150) A (150 to 1025) A	0.23 % + 13 mA 0.25 % + 22 mA	Fluke 5520A w/ Fluke 5500A/coil
DC Current – Generate	(0 to 199.9) μA (0.2 to 1.999) mA (2 to 19.99) mA (20 to 199.99) mA (0.2 to 1.999) A	0.010 % + 0.001 8 μA 0.0054 % + 0.000018 mA 0.0060 % + 0.000091 mA 0.0052 % + 0.00090 mA 0.014 % + 0.000 022 A	Wavetek 4808
Resistance – Generate <sup>3</sup> , Fixed Points	10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ	0.33 mΩ 1.5 mΩ 14 mΩ 0.14 Ω 1.8 Ω 37 Ω 0.74 kΩ 22 kΩ	Wavetek 4808

Parameter/Equipment	Range	CMC <sup>2,8</sup> (±)	Comments
Resistance – Measure and Generate <sup>3</sup>	(1 to 11) mΩ	0.052 %	Leeds and Northrup 4300 w/HP 3458A opt 002
	11 mΩ to 10 Ω	13 μΩ/Ω + 0.10 mΩ	Fluke 5520A w/HP 3458A
	(10 to 100) Ω	13 μΩ/Ω + 0.72 mΩ	
	100 Ω to 1 kΩ	11 μΩ/Ω + 1.6 mΩ	
	(1 to 10) kΩ	10 μΩ/Ω + 19 mΩ	
	(10 to 100) kΩ	11 μΩ/Ω + 0.12 Ω	
	100 kΩ to 1 MΩ	15 μΩ/Ω + 5.4 Ω	
	(1 to 10) MΩ	50 μΩ/Ω + 0.20 kΩ	
	(10 to 100) MΩ	0.058 % + 1.4 kΩ	
	100 MΩ to 1 GΩ	0.58 % + 11 kΩ	

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
Capacitance – Generate <sup>3</sup>			Fluke 5520A
(0.19 to 0.4) nF	10 Hz to 10 kHz	0.51 % + 8.7 pF	
(0.4 to 1.1) nF	10 Hz to 10 kHz	0.34 % + 8.9 pF	
(1.1 to 3.3) nF	10 Hz to 3 kHz	0.38 % + 9.0 pF	
(3.3 to 11) nF	10 Hz to 1 kHz	0.20 % + 8.9 pF	
(11 to 33) nF	10 Hz to 1 kHz	0.20 % + 80 pF	
(33 to 110) nF	10 Hz to 1 kHz	0.20 % + 82 pF	
(110 to 330) nF	10 Hz to 1 kHz	0.20 % + 0.24 nF	
330 nF to 1.1 μF	(10 to 300) Hz	0.20 % + 0.82 nF	
(1.1 to 3.3) μF	(10 to 300) Hz	0.20 % + 2.5 nF	
(3.3 to 11) μF	(10 to 150) Hz	0.20 % + 82 pF	
(11 to 33) μF	(10 to 120) Hz	0.32 % + 24 nF	
(33 to 110) μF	(10 to 80) Hz	0.37 % + 78 nF	
(110 to 330) μF	(0 to 50) Hz	0.37 % + 0.24 μF	
330 μF to 1.1 mF	(0 to 20) Hz	0.35 % + 0.92 μF	
(1.1 to 3.3) mF	(0 to 6) Hz	0.36 % + 2.4 μF	
(3.3 to 11) mF	(0 to 2) Hz	0.36 % + 8.1 μF	
(11 to 33) mF	(0 to 0.6) Hz	0.22 % + 69 μF	
(33 to 110) mF	(0 to 0.2) Hz	0.88 % + 80 μF	

Parameter/Range	Frequency	CMC <sup>2, 8</sup> (±)	Comments
Capacitance – Generate and Measure  (1 to 10) pF (10 to 100) pF (100 to 400) pF (400 to 1 000) pF (1 to 10) nF (10 to 100) nF (100 to 1 000) nF (1 to 10) μF (10 to 100) μF (100 to 1 000) μF	1 kHz	0.012 % + 0.046 pF 0.012 % + 0.046 pF 0.012 % + 0.046 pF 0.023 % + 0.00026 pF 0.023 % + 0.000007 6 nF 0.023 % + 0.000078 nF 0.023 % + 0.00077 nF 0.023 % + 0.000007 2 μF 0.062 % - 0.003 8 μF 0.52 % - 0.46 μF	Genrad 1689M w/ capacitance source
Inductance – Generate and Measure  (0.1 to 1) mH (1 to 10) mH (10 to 100) mH (100 to 1000) mH (1 to 10) H	1 kHz	0.012 % + 0.00012 mH 0.023 % 0.023 % 0.023 % 0.023 %	Genrad 1689M w/ inductance source

Parameter/Equipment	Range	CMC <sup>2, 8</sup> (±)	Comments
Capacitance – Generate, Cardinal points only	Nominal 1 pF 10 pF 100 pF 1000 pF 1 nF 10 nF 100 nF 1000 nF	0.14 % of charted value 0.12 % of charted value 0.12 % of charted value 0.12 % of charted value 0.058 % of charted value 0.058 % of charted value 0.058 % of charted value 0.058 % of charted value	HP 16380A & GR 1409 series standard capacitors

Parameter/Equipment	Range	CMC <sup>2,8</sup> (±)	Comments
DC Power <sup>3</sup> –  33 mV to 1020 V (0.33 to 330) mA (0.33 to 3) A (3 to 20.5) A	DC DC DC	0.022 % + 48 μW 0.020 % + 0.18 mW 0.063 % - 0.24 mW	Fluke 5520A
AC Power <sup>3</sup>  (33 to 330) mV @ (3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA (330 to 900) mA (0.9 to 2.2) A (2.2 to 4.5) A (4.5 to 20.5) A  330 mV to 1 020 V @ (3.3 to 9) mA (9 to 33) mA (33 to 90) mA (90 to 330) mA (330 to 900) mA (0.9 to 2.2) A (2.2 to 4.5) A (4.5 to 20.5) A	45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz  45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz 45 to 65 Hz	0.27 % - 0.024 μW 0.11 % + 0.18 μW 0.13 % + 0.028 W 0.091 % + 0.032 μW 0.12 % - 0.42 μW 0.10 % + 2.3 μW 0.12 % - 1.2 μW 0.10 % + 7.0 μW  0.11 % + 0.29 μW 0.10 % - 0.27 mW 0.11 % - 0.035 μW 0.073 % - 0.65 mW 0.11 % - 0.59 mW 0.084 % - 0.18 mW 0.11 % + 21 mW 0.091 % + 1.1 mW	Fluke 5520A
Electrical Calibration of RTD Indicators and Indicating Systems <sup>3</sup> –  Pt 385, 3926, 100 Ω  Pt 385 Only	-200 °C to 0 °C 0 °C to 100 °C 100 °C to 300 °C 300 °C to 400 °C 400 °C to 630 °C  630 °C to 800 °C	0.050 °C 0.060 °C 0.080 °C 0.090 °C 0.11 °C  0.21 °C	Fluke 5520A



Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Electrical Calibration of RTD Indicators and Indicating Systems <sup>3</sup> – (cont)			
Pt 3916, 100 Ω	-200 °C to -190 °C -190 °C to -80 °C -80 °C to 100 °C 100 °C to 260 °C 260 °C to 300 °C 300 °C to 400 °C 400 °C to 600 °C 600 °C to 630 °C	0.23 °C 0.040 °C 0.050 °C 0.060 °C 0.070 °C 0.080 °C 0.090 °C 0.21 °C	Fluke 5520A
Pt 385, 200 Ω	-200 °C to 100 °C 100 °C to 260 °C 260 °C to 300 °C 300 °C to 400 °C 400 °C to 600 °C 600 °C to 630 °C	0.040 °C 0.050 °C 0.11 °C 0.12 °C 0.13 °C 0.14 °C	
Pt 385, 500 Ω	-200 °C to -80 °C -80 °C to 260 °C 260 °C to 400 °C 400 °C to 600 °C 600 °C to 630 °C	0.040 °C 0.050 °C 0.070 °C 0.08 °C 0.10 °C	
Pt 385, 1000 Ω	-200 °C to 0 °C 0 °C to 100 °C 100 °C to 300 °C 300 °C to 600 °C 600 °C to 630 °C	0.030 °C 0.040 °C 0.050 °C 0.060 °C 0.21 °C	
PtNi 385, 120 Ω	-80 °C to 100 °C 100 °C to 260 °C	0.070 °C 0.13 °C	
Cu 427, 10 Ω	-100 °C to 260 °C	0.27 °C	

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Electrical Calibration of Thermocouple Indicators and Indicating Systems <sup>3</sup> –			
Type E	-250 °C to -100 °C -100 °C to -25 °C -25 °C to 350 °C 350 °C to 650 °C 650 °C to 1000 °C	0.42 °C 0.14 °C 0.13 °C 0.16 °C 0.18 °C	Fluke 5520A
Type J	-210 °C to -100 °C -100 °C to -30 °C -30 °C to 150 °C 150 °C to 760 °C 760 °C to 1200 °C	0.42 °C 0.18 °C 0.17 °C 0.15 °C 0.19 °C	
Type K	-200 °C to -100 °C -100 °C to -25 °C -25 °C to 120 °C 120 °C to 1000 °C 1000 °C to 1372 °C	0.28 °C 0.19 °C 0.16 °C 0.22 °C 0.33 °C	
Type T	-250 °C to -150 °C -150 °C to 0 °C 0 °C to 120 °C 120 °C to 400 °C	0.51 °C 0.20 °C 0.14 °C 0.13 °C	
Thermistors	-80 °C to -40 °C -40 °C to 100 °C 100 °C to 150 °C	0.084 °C 0.0063 °C 0.0095 °C	Decade resistance boxes

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
AC Voltage – Generate <sup>3</sup>			
(0.09 to 1.999) mV	(10 to 31) Hz (32 to 330) Hz 300 Hz to 10 kHz (10 to 33) kHz (30 to 100) kHz (100 to 330) kHz 300 kHz to 1 MHz	0.014 % + 0.0055 mV 0.016 % + 0.0054 mV 0.016 % + 0.0054 mV 0.033 % + 0.0054 mV 0.052 % + 0.0055 mV 0.12 % + 0.022 mV 0.25 % + 0.025 mV	Wavetek 4808
(0.9 to 19.99) mV	(10 to 31) Hz (32 to 330) Hz 300 Hz to 10 kHz (10 to 33) kHz (30 to 100) kHz (100 to 330) kHz 300 kHz to 1 MHz	0.020 % + 0.0052 mV 0.017 % + 0.0052 mV 0.017 % + 0.0052 mV 0.027 % + 0.0052 mV 0.050 % + 0.0052 mV 0.12 % + 0.021 mV 0.24 % + 0.025 mV	
(9 to 199.999) mV	(10 to 31) Hz (32 to 330) Hz 300 Hz to 10 kHz (10 to 33) kHz (30 to 100) kHz (100 to 330) kHz 300 kHz to 1 MHz	0.017 % + 0.0090 mV 0.013 % + 0.0087 mV 0.012 % + 0.0083 mV 0.023 % + 0.0083 mV 0.046 % + 0.0084 mV 0.12 % + 0.036 mV 0.24 % + 0.13 mV	
(0.09 to 1.999) V	(10 to 31) Hz (32 to 330) Hz 300 Hz to 33 kHz (30 to 100) kHz (100 to 330) kHz 300 kHz to 1 MHz	0.012 % + 0.000033 V 0.0076 % + 0.000019 V 0.0076 % + 0.0000094 V 0.014 % + 0.000019 V 0.040 % + 0.000090 V 0.23 % + 0.00036 V	
(0.9 to 19.99) V	(10 to 31) Hz (32 to 330) Hz 300 Hz to 33 kHz (30 to 100) kHz (100 to 330) kHz 300 kHz to 1 MHz	0.013 % + 0.00028 V 0.0077 % + 0.00018 V 0.0077 % + 0.000091 V 0.014 % + 0.00019 V 0.038 % + 0.0045 V 0.22 % + 0.0045 V	

Parameter/Range	Frequency	CMC <sup>2, 8</sup> (±)	Comments
AC Voltage – Generate <sup>3</sup> (cont)			
(9 to 199.999) V	(10 to 31) Hz (32 to 330) Hz 300 Hz to 10 kHz (10 to 33) kHz (30 to 100) kHz	0.018 % + 0.00092 V 0.011 % + 0.0018 V 0.0077 % + 0.00092 V 0.0087 % + 0.0018 V 0.028 % + 0.0027 V	Wavetek 4808
(9 to 100.000) V	(100 to 330) kHz	0.098 % + 0.042 V	
(90 to 1100) V	(10 to 31) Hz (to 500 V only) (32 to 330) Hz 300 Hz to 3.3 kHz (3 to 10) kHz (10 to 33) kHz (30 to 100) kHz	0.014 % + 0.050 V 0.016 % + 0.044 V 0.013 % + 0.038 V 0.013 % + 0.039 V 0.015 % + 0.061 V 0.093 % + 0.20 V	
AC Voltage – Generate <sup>3</sup>			
(1 to 33) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.072 % + 5.5 μV 0.014 % + 5.5 μV 0.018 % + 5.5 μV 0.090 % + 5.5 μV 0.31 % + 11 μV 0.72 % + 45 μV	Fluke 5520A
(33 to 330) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.027 % + 7.2 μV 0.012 % + 7.2 μV 0.014 % + 7.2 μV 0.032 % + 7.2 μV 0.072 % + 29 μV 0.18 % + 63 μV	
330 mV to 3.3 V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.027 % + 45 μV 0.011 % + 23 μV 0.017 % + 45 μV 0.027 % + 45 μV 0.063 % + 0.11 mV 0.22 % + 0.54 mV	

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
AC Voltage – Generate <sup>3</sup> (cont)  (750 to 1020) V	45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.022 % + 15 V 0.018 % + 16 V 0.022 % + 15 V	Fluke 5520A
AC Voltage – Measure <sup>3</sup>  Up to 10 mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.048 % + 4.0 μV 0.027 % + 1.5 μV 0.040 % + 1.5 μV 0.13 % + 1.5 μV 0.67 % + 1.5 μV 0.53 % + 2.7 μV	HP 3458A opt 002
(10 to 100) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.027 % + 5.8 μV 0.0094 % + 3.2 μV 0.019 % + 2.7 μV 0.040 % - 2.7 μV 0.11 % + 2.7 μV 0.40 % + 13 μV 1.3 % + 1.3 μV	
100 mV to 1 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.027 % + 56 μV 0.0094 % + 28 μV 0.019 % + 27 μV 0.040 % + 27 μV 0.11 % + 27 μV 0.40 % + 0.23 mV 1.3 % + 0.13 mV	
(1 to 10) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.0096 % + 0.55 mV 0.0095 % + 0.27 mV 0.019 % + 0.27 mV 0.040 % + 0.27 mV 0.11 % + 0.27 mV 0.40 % + 1.3 mV 1.3 % + 1.3 mV	

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
AC Voltage – Measure <sup>3</sup> (cont)			
(10 to 100) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.027 % + 5.4 mV 0.027 % + 2.7 mV 0.027 % + 2.7 mV 0.047 % + 2.7 mV 0.16 % + 2.7 mV 0.53 % + 13 mV	HP 3458A opt 002
(100 to 750) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.053 % + 56 mV 0.054 % + 26 mV 0.080 % + 27 mV 0.16 % + 27 mV 0.40 % + 27 mV	
(0.7 to 5) kV	60 Hz	0.16 % - 1.2 V	Fluke 80E -10 w/ HP3458A opt 002
AC Current – Generate <sup>3</sup>			
(20 to 199.9) µA	10 Hz to 1 kHz (1 to 5) kHz	0.017 % + 0.0090 µA 0.035 % + 0.13 µA	Wavetek 4808
(0.2 to 1.999) mA	10 Hz to 1 kHz (1 to 5) kHz	0.013 % + 0.000091 mA 0.026 % + 0.00013 mA	
(2 to 19.99) mA	10 Hz to 1 kHz (1 to 5) kHz	0.012 % + 0.00090 mA 0.026 % + 0.00090 mA	
(20 to 199.99) mA	10 Hz to 1 kHz (1 to 5) kHz	0.012 % + 0.0090 mA 0.026 % + 0.0092 mA	
(0.2 to 1.999) A	10 Hz to 1 kHz (1 to 5) kHz	0.014 % + 0.00012 A 0.020 % + 0.00023 A	
(3 to 11) A	45 to 100) Hz (100 to 1000) Hz (1 to 5) kHz	0.056 % + 1.8 mA 0.091 % + 1.8 mA 2.7 % + 1.8 mA	
(11 to 20) A	(45 to 100) Hz (100 to 1000) Hz (1 to 5) kHz	0.11 % + 4.4 mA 0.14 % + 4.4 mA 2.7 % + 4.5 mA	Fluke 5520A

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
AC Current – Measure <sup>3</sup>			
Up to 100 µA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % + 23 nA 0.17 % + 23 nA 0.070 % + 23 nA 0.070 % + 23 nA	HP 3458A opt 002
100 µA to 1 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	0.17 % + 23 µA 0.17 % + 0.23 µA 0.070 % + 0.23 µA 0.035 % + 0.23 µA 0.068 % + 0.25 µA 0.46 % + 0.46 µA	
(1 to 10) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	0.46 % + 2.3 µA 0.17 % + 2.3 µA 0.070 % + 2.3 µA 0.035 % + 2.3 µA 0.070 % + 2.3 µA 0.46 % + 4.6 µA	
(10 to 100) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	0.46 % + 23 µA 0.17 % + 23 µA 0.070 % + 23 µA 0.035 % + 23 µA 0.070 % + 23 µA 0.46 % + 46 µA	
100 mA to 1 A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz	0.46 % + 0.23 mA 0.46 % + 0.23 mA 0.093 % + 0.23 mA 0.12 % + 0.23 mA 0.35 % + 0.23 mA	

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
AC Current – Measure <sup>3</sup> (cont)			
Measure Only (1 to 20) A	45 Hz to 1 kHz (1 to 5) kHz	0.31 % + 65 μA 0.046 % + 0.21 mA	HP 3458A opt 002 w/Fluke Y5020 shunt

Parameter/Equipment	Frequency	CMC <sup>2,8</sup> (±)	Comments
Distortion (THD)	20 Hz to 20 kHz (20 to 100) kHz	14 % of THD 30 % of THD	HP 8903A
Oscilloscopes <sup>3</sup> –			
DC and Square Wave	Into 50 Ω	0.2 % + 32 μV	Fluke 5520A/SC600
DC Only	Into 1 MΩ	0.040 % + 32 μV	
Square Wave	Into 1 MΩ	0.090 % + 32 μV	
Leveled Sine Wave	50 kHz Reference	1.7 % + 0.24 mV	
	Relative to 50 kHz Reference		
	50 kHz to 100 MHz	1.3 % + 80 μV	Fluke 5522A/SC1100
	(100 to 300) MHz	1.7 % + 80 μV	
	(300 to 600) MHz	3.3 % + 80 μV	
	(600 to 1 100) MHz	5.8 % + 0.12 mV	
Time Marker	5 s to 50 ms 20 ms to 2 ns	0.20% - 0.36 ms 2.3 μs/s	



IV. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
Relative Power –  (0 to -10) dBm (-10 to -20) dBm (-20 to -30) dBm (-30 to -40) dBm (-40 to -50) dBm (-50 to -60) dBm (-60 to -70) dBm (-70 to -80) dBm (-80 to -90) dBm (-90 to -100) dBm (-100 to -110) dBm (-110 to -120) dBm	2.5 MHz to 26.5 GHz           (2.5 to 1300) MHz	0.024 dB 0.037 dB 0.045 dB 0.062 dB 0.081 dB 0.084 dB 0.099 dB 0.12 dB 0.13 dB 0.14 dB 0.15 dB 0.17 dB	HP 8902A w/ 11793A
Absolute Power –  (20 to 30) dBm  (10 to 20) dBm  (0 to 10) dBm  (-10 to 0) dBm  (-20 to -10) dBm	100 kHz to 2.6 GHz (2.6 to 12) GHz (12 to 26.5) GHz  100 kHz to 2.6 GHz (2.6 to 12) GHz (12 to 26.5) GHz  100 kHz to 2.6 GHz (2.6 to 12) GHz (12 to 26.5) GHz  100 kHz to 2.6 GHz (2.6 to 12) GHz (12 to 26.5) GHz	0.26 dB 0.28 dB 0.32 dB  0.23 dB 0.25 dB 0.30 dB  0.21 dB 0.23 dB 0.28 dB  0.34 dB 0.24 dB 0.30 dB  0.27 dB 0.29 dB 0.34 dB	HP 8902A w/ 11793A, HP 11722A, HP 11792A
High RF Power – Measure  (0.3 to 1000) W	25 MHz to 1 GHz	3.3 %	Bird 4421A w/ 4022A

Parameter/Range	Frequency	CMC <sup>2,8</sup> (±)	Comments
Amplitude Modulation –  Carrier: 150 kHz to 10 MHz Depth: Up to 99 %  Carrier: (0.1 to 1.3) GHz Depth: Up to 99 %	(20 to 50) Hz (0.05 to 100) kHz  (20 to 50) Hz (0.05 to 100) kHz	3.0 % 2.0 %  1.1 % 3.0 %	HP 8902A
Frequency Modulation –  Carrier: (0.25 to 10) MHz Dev: Up to 40 kHz  Carrier: (0.01 to 1.3) GHz Dev: Up to 400 kHz	(0.02 to 10) kHz   (0.05 to 100) kHz (100 to 200) kHz	2.3 % + 12 Hz   1.2 % + 0.12 kHz 5.8 % + 0.12 kHz	HP 8902A
Phase Modulation –  Carrier (0.15 to 10) MHz Carrier (0.01 to 1.3) GHz	(0.2 to 10) kHz (0.2 to 20) kHz	4.8 % + 0.012 rad 3.7 % + 0.12 rad	HP 8902A

#### V. Mechanical

Parameter/Equipment	Range	CMC <sup>2,8</sup> (±)	Comments
Force – Measure and Measuring Equipment <sup>3,5</sup>	(0 to 500) lbf	0.038 %	Dead weight
Mass	1 mg to 1 g (>1 to 10) g (>10 to 210) g (>210 to 6.1) kg	0.0080 mg (0.0021 - 0.00018X) % 0.000090 % (0.000 66 - 0.000083Y) %	Troemner weights and comparators  X in g  Y in kg

Parameter/Equipment	Range	CMC <sup>2, 8</sup> ( $\pm$ )	Comments
Scales and Balances <sup>3,5</sup>	1 mg to 1 g	0.0050 mg	Troemner weights
	(1 to 10) g	(0.00048 – 0.000038X) %	X in g
	10 g to 11 kg	0.000060 %	
	(11 to 200) kg	0.12 %	Class F weights
Volume <sup>3</sup>	(0.5 to 2) $\mu$ L	0.040 $\mu$ L	Balances V is the volume in $\mu$ L
	(2 to 20) $\mu$ L	0.052 $\mu$ L	
	(20 to 200) $\mu$ L	(0.037 + 0.0033 · V) $\mu$ L	
	(200 to 1000) $\mu$ L	(0.26 + 0.0020 · V) $\mu$ L	
Torque – Measure and Measuring Equipment <sup>3</sup>	2 in·lbf to 2000 ft·lbf	0.25 %	AKO torque system
	Measuring Equipment Only <sup>5</sup>	(1 to 200) in·lbf	0.13 % Torque arm and weights
Pressure/Vacuum – Measure and Measuring Equipment <sup>3</sup>	(0 to 2) in H <sub>2</sub> O	0.000 60 in H <sub>2</sub> O	MicroTector
	(0 to 10) psia (>10 to 1 015) psia	0.012 psi 0.011 %	DHI PPC3
	Measure and Measuring equipment <sup>3,5</sup>	(1000 to 10 000) psig	0.12 % Digital pressure gauges and pressure pump
Durometers <sup>3,5</sup>			
Types A, B, C, D, DO, O	(0 to 100) points	(0.00060 + 0.00040 rdg) points	ASTM D2240

VI. Thermodynamics

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Temperature – Measure <sup>3</sup>	(-200 to -20) °C	0.033 °C	Fluke 5609, Hart 1529
Temperature – Measure and Measuring Equipment <sup>3</sup>	-196 °C	0.029 °C	Liquid N <sub>2</sub> , Fluke 5609, Hart 1529
	(-70 to -20) °C	0.033 °C	Fluke 5609, Hart 1529 with solid CO <sub>2</sub> and Isopropyl alcohol
	(-20 to 150) °C	0.033 °C	w/ Fluke 7320
	(150 to 200) °C	0.044 °C	w/ Fluke 6102
	(200 to 425) °C	0.053 °C	w/ Fluke 9172
	(425 to 650) °C	0.089 °C	w/ Hart 9127
	Ice Point (generate only)	0.0027 °C	ASTM E563 ice point
Temperature – Measure and Measuring Equipment <sup>3</sup>	(35 to 500) °C	(0.30 + 0.0040 rdg) °C	Fluke 4181
Relative Humidity – Measure and Measuring Equipment <sup>3,5</sup>	(10 to 95) % RH	0.5 % RH	Thunder Scientific 1200

VII. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2,7</sup> (±)	Comments
Frequency – Measuring Equipment <sup>5</sup>	10 MHz Reference	5 parts in 10 <sup>12</sup> Hz	HP Z3801A GPS
	1 mHz to 26.5 GHz	5 parts in 10 <sup>12</sup> + 0.6R Hz	HP Z3801A GPS locked with signal generator
Frequency – Measure <sup>5</sup>	1 mHz to 26.5 GHz	5 parts in 10 <sup>12</sup> + 0.6R Hz	HP Z3801A GPS locked with frequency counter

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Frequency – Measure and Measuring Equipment <sup>3</sup>	(0.01 to 10) Hz (10 to 100) Hz 100 Hz to 26.5 GHz	1.1 part in 10 <sup>3</sup> Hz 4.1 part in 10 <sup>6</sup> Hz 1.1 part in 10 <sup>7</sup> Hz	HP 5345B

<sup>1</sup> This laboratory offers commercial calibration service and field calibration service, where noted.

<sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of  $k = 2$ . The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

<sup>3</sup> Field calibration service is available for this calibration and this laboratory meets A2LA R104 – *General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

<sup>4</sup> In the statement of CMC,  $L$  is the numerical value of the nominal length of the device measured in inches.  $D$  is the numerical value of the nominal diameter of the device measured in inches except where noted.  $R$  is the resolution of the unit under test.

<sup>5</sup> The contributions from the “best existing device” are not included in the CMC claim.

<sup>6</sup> "Supermicrometer" is a registered trade mark with a last listed owner of Pratt & Whitney Measurement Systems, Inc., Connecticut U.S.A.

<sup>7</sup>  $R$  is the resolution of the signal generator or counter.

<sup>8</sup> Unless otherwise indicated all units listed in % means % of reading.



## Accredited Laboratory

A2LA has accredited

### WESCAN CALIBRATION

*Richmond, British Columbia CANADA*

for technical competence in the field of

### Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and the requirements of ANSI/NCSLI Z540.3-2006 and any additional program requirements in the field of calibration. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009*).



Presented this 26<sup>th</sup> day of June 2015.

A handwritten signature in black ink, reading "Peter Abney".

President & CEO  
For the Accreditation Council  
Certificate Number 1500.02  
Valid to January 31, 2017

*For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.*